

Search Notes

Application/Control No.

10/017,672

Examiner

Mark L. Shibuya

Applicant(s)/Patent under
Reexamination

NISHIKAWA ET AL.

Art Unit

1639

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
PALM, inventor search	7/8/2005	MS
WEST, inventor, term search	7/8/2005	MS
STN, inventor, term search	7/8/2005	MS
WEST, term search	7/10/2005	MS
STN, term search	7/10/2005	ms